

Notice of References Cited	Application/Control No. 10/573,676		Applicant(s)/Patent Under Reexamination NEUHAUS ET AL.	
	Examiner BENJAMIN ELLIOTT		Art Unit 2416	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0116464	08-2002	Mak, Joon Mun	709/206
*	B	US-5,093,827	03-1992	Franklin et al.	370/354
*	C	US-6,085,238	07-2000	Yuasa et al.	709/223
*	D	US-6,487,180	11-2002	Borgstahl et al.	370/310
*	E	US-5,530,744	06-1996	Charalambous et al.	379/266.08
*	F	US-6,269,099	07-2001	Borella et al.	370/389
*	G	US-7,027,435	04-2006	Bardehle, Lutz	370/352
*	H	US-6,463,146	10-2002	Hartley et al.	379/215.01
*	I	US-6,141,413	10-2000	Waldner et al.	379/88.17
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.